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Radhakrishnan, R.; Moore, L.; Wilsey, P.A.;

Parallel Processing Symposium, 1997. Proceedings., 11th International

1-5 April 1997 Page(s):260 - 266

Digital Object Identifier 10.1109/IPPS.1997.580905

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2. Flexible Simulation Data Collection and Replay Tool

Wei Li; Ming Yang; Zi-Cai Wang;

Machine Learning and Cybernetics, 2006 International Conference on

Aug. 2006 Page(s):1210 - 1215

Digital Object Identifier 10.1109/ICMLC.2006.258607

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